

Search Notes

Application/Control No.

10/617,363

Examiner

German Viana Di Prisco

Applicant(s)/Patent under
Reexamination

WU ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search in EAST Image and keyword search in USPAT, US-PGPUB, DERWENT,EPO,JPO and IBM_TDB (see attached search strateg	12/27/2007	GV
Consulted with Duc Nguyen	12/27/2007	GV